Applicant(s)/Patent Under Reexamination Application/Control No. 10/710,916 ABE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2615 HUYEN D. LE **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,239,943	12-1980	Czerwinski, Eugene J.	381/404
*	В	US-6,763,120	07-2004	Sugiyama et al.	381/395
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			. 1
	Н	US-			
	Т	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.